## Application/Control No. Notice of References Cited Application/Control No. 09/852,819 Examiner Man Phan Applicant(s)/Patent Under Reexamination HWANG ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,771,670	08-2004	Pfahler et al.	370/503
	В	US-6,636,993	10-2003	Koyanagi et al.	714/700
	С	US-6,173,380	01-2001	Jin et al.	711/167
	D	US-6,650,638	11-2003	Walker et al.	370/389
	Е	US-5,802,122	09-1998	Niegel, Michael	375/372
	F	US-6,606,675	08-2003	Godbole, Anil V.	710/100
	G	US-5,461,621	10-1995	Little, Vernon R.	370/470
	Н	US-6,738,393	05-2004	Miki et al.	370/506
	1	US-6,397,367	05-2002	Park et al.	714/786
	J	US-2002/0122435	09-2002	Mundkur et al.	370/503
	К	US-2003/0031202	02-2003	Teng, Chia-Yuan	370/469
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R		•			
	S					·
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	x	

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